

Dual NPN wideband transistor

BFM520

FEATURES

- Small size
- Temperature and h_{FE} matched
- Low noise and high gain
- High gain at low current and low capacitance at low voltage
- Gold metallization ensures excellent reliability.

APPLICATIONS

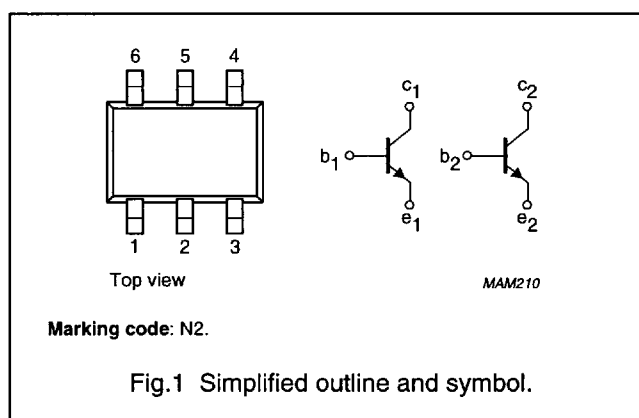
- Oscillator and buffer amplifiers
- Balanced amplifiers
- LNA/mixers.

DESCRIPTION

Dual transistor with two silicon NPN RF dies in a surface mount 6-pin SOT363 (S-mini) package. The transistor is primarily intended for wideband applications in the GHz-range in the RF front end of analog and digital cellular phones, cordless phones, radar detectors, pagers and satellite TV-tuners.

PINNING - SOT363A

PIN	SYMBOL	DESCRIPTION
1	b_1	base 1
2	e_1	emitter 1
3	c_2	collector 2
4	b_2	base 2
5	e_2	emitter 2
6	c_1	collector 1



QUICK REFERENCE DATA

SYMBOL	PARAMETER	CONDITIONS	MIN.	TYP.	MAX.	UNIT
Any single transistor						
C_{re}	feedback capacitance	$I_e = 0$; $V_{CB} = 3$ V; $f = 1$ MHz	—	0.4	—	pF
f_T	transition frequency	$I_C = 20$ mA; $V_{CE} = 3$ V; $f = 900$ MHz	—	9	—	GHz
$ S_{21} ^2$	insertion power gain	$I_C = 20$ mA; $V_{CE} = 3$ V; $f = 900$ MHz; $T_{amb} = 25$ °C	13	14.5	—	dB
G_{UM}	maximum unilateral power gain	$I_C = 20$ mA; $V_{CE} = 3$ V; $f = 900$ MHz; $T_{amb} = 25$ °C	—	15	—	dB
F	noise figure	$I_C = 5$ mA; $V_{CE} = 3$ V; $f = 900$ MHz; $\Gamma_S = \Gamma_{opt}$	—	1.2	1.6	dB
$R_{th\ j-s}$	thermal resistance from junction to soldering point	single loaded	—	—	230	K/W
		double loaded	—	—	115	K/W

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LIMITING VALUES

In accordance with the Absolute Maximum System (IEC 134).

SYMBOL	PARAMETER	CONDITIONS	MIN.	MAX.	UNIT
Any single transistor					
V_{CBO}	collector-base voltage	open emitter	–	20	V
V_{CEO}	collector-emitter voltage	open base	–	8	V
V_{EBO}	emitter-base voltage	open collector	–	2.5	V
I_C	DC collector current		–	70	mA
P_{tot}	total power dissipation	up to $T_s = 118\text{ }^{\circ}\text{C}$; note 1	–	1	W
T_{stg}	storage temperature		–65	+175	$^{\circ}\text{C}$
T_j	junction temperature		–	175	$^{\circ}\text{C}$

THERMAL CHARACTERISTICS

SYMBOL	PARAMETER	CONDITIONS	VALUE	UNIT
$R_{th\ j-s}$	thermal resistance from junction to soldering point; note 1	single loaded	230	K/W
		double loaded	115	K/W

Note to the Limiting values and Thermal characteristics

- T_s is the temperature at the soldering point of the collector pin.

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CHARACTERISTICS

 $T_j = 25\text{ }^{\circ}\text{C}$ unless otherwise specified.

SYMBOL	PARAMETER	CONDITIONS	MIN.	TYP.	MAX.	UNIT
DC characteristics of any single transistor						
$V_{(BR)CBO}$	collector-base breakdown voltage	$I_C = 2.5\text{ }\mu\text{A}; I_E = 0$	20	—	—	V
$V_{(BR)CEO}$	collector-emitter breakdown voltage	$I_C = 10\text{ }\mu\text{A}; I_B = 0$	8	—	—	V
$V_{(BR)EBO}$	emitter-base breakdown voltage	$I_E = 2.5\text{ }\mu\text{A}; I_C = 0$	2.5	—	—	V
I_{CBO}	collector-base leakage current	$V_{CB} = 6\text{ V}; I_E = 0$	—	—	50	nA
h_{FE}	DC current gain	$I_C = 20\text{ mA}; V_{CE} = 6\text{ V}$	60	120	250	
DC characteristics of the dual transistor						
Δh_{FE}	ratio of highest and lowest DC current gain	$I_{C1} = I_{C2} = 20\text{ mA}; V_{CE1} = V_{CE2} = 6\text{ V}$	1	1.2	—	
ΔV_{BEO}	difference between highest and lowest base-emitter voltage (offset voltage)	$I_{E1} = I_{E2} = 30\text{ mA}; T_{amb} = 25\text{ }^{\circ}\text{C}$	0	1	—	mV
AC characteristics of any single transistor						
f_T	transition frequency	$I_C = 20\text{ mA}; V_{CE} = 3\text{ V}; f = 1\text{ GHz}$	—	9	—	GHz
C_c	collector capacitance	$I_E = I_B = 0; V_{CB} = 3\text{ V}; f = 1\text{ MHz}$	—	0.5	—	pF
C_{re}	feedback capacitance	$I_C = 0; V_{CB} = 3\text{ V}; f = 1\text{ MHz}$	—	0.4	—	pF
G_{UM}	maximum unilateral power gain; note 1	$I_C = 20\text{ mA}; V_{CE} = 3\text{ V}; T_{amb} = 25\text{ }^{\circ}\text{C}; f = 900\text{ MHz}$	—	15	—	dB
		$I_C = 20\text{ mA}; V_{CE} = 3\text{ V}; T_{amb} = 25\text{ }^{\circ}\text{C}; f = 2\text{ GHz}$	—	9	—	dB
$ s_{21} ^2$	insertion power gain	$I_C = 20\text{ mA}; V_{CE} = 3\text{ V}; f = 900\text{ MHz}; T_{amb} = 25\text{ }^{\circ}\text{C}$	13	14.5	—	dB
F	noise figure	$I_C = 5\text{ mA}; V_{CE} = 3\text{ V}; f = 900\text{ MHz}; \Gamma_S = \Gamma_{opt}$	—	1.2	1.6	dB
		$I_C = 20\text{ mA}; V_{CE} = 3\text{ V}; f = 900\text{ MHz}; \Gamma_S = \Gamma_{opt}$	—	1.7	2.1	dB
		$I_C = 5\text{ mA}; V_{CE} = 3\text{ V}; f = 2\text{ GHz}; \Gamma_S = \Gamma_{opt}$	—	1.9	—	dB

Note

1. G_{UM} is the maximum unilateral power gain, assuming s_{12} is zero. $G_{UM} = 10 \log \frac{|s_{21}|^2}{(1 - |s_{11}|^2)(1 - |s_{22}|^2)}$ dB

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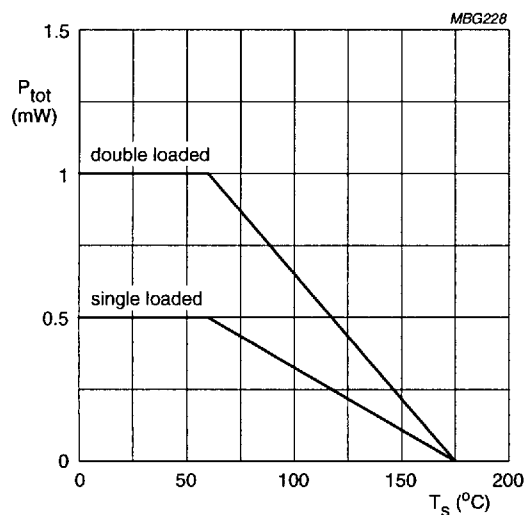
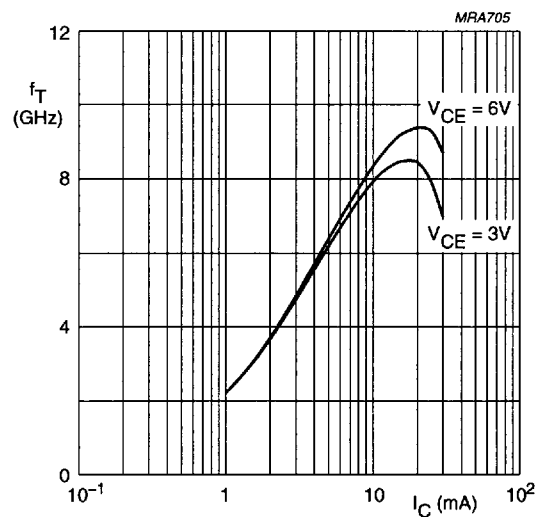
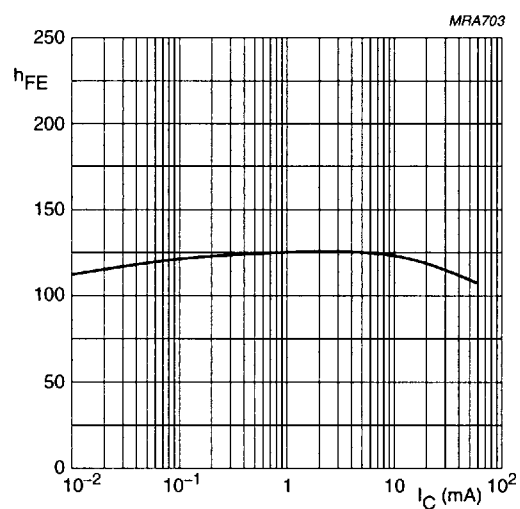


Fig.2 Power derating as a function of soldering point temperature; typical values.



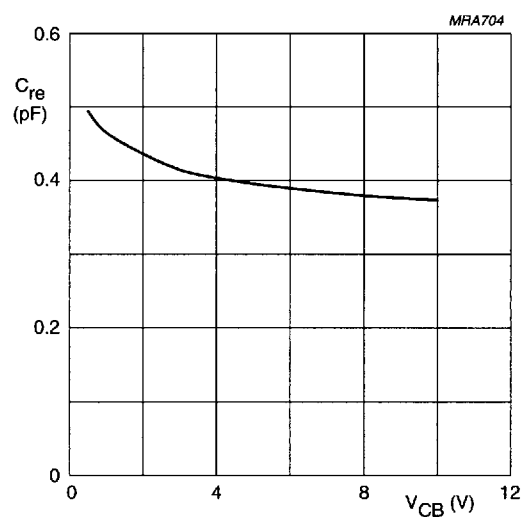
$f = 1$ GHz; $T_{amb} = 25$ °C.

Fig.3 Transition frequency as a function of collector current; typical values.



$V_{CE} = 6$ V.

Fig.4 DC current gain as a function of collector current; typical values.

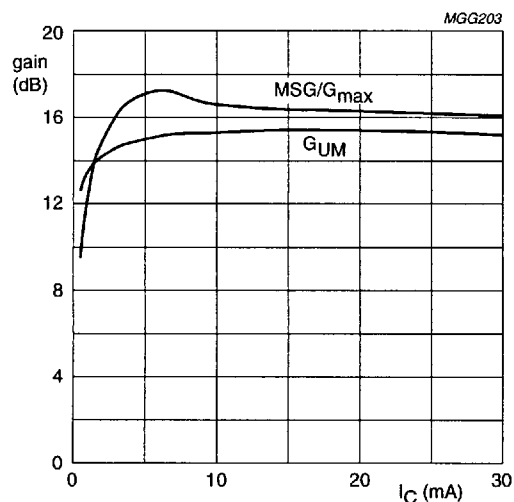


$I_C = 0$; $f = 1$ MHz.

Fig.5 Feedback capacitance as a function of collector-base voltage; typical values.

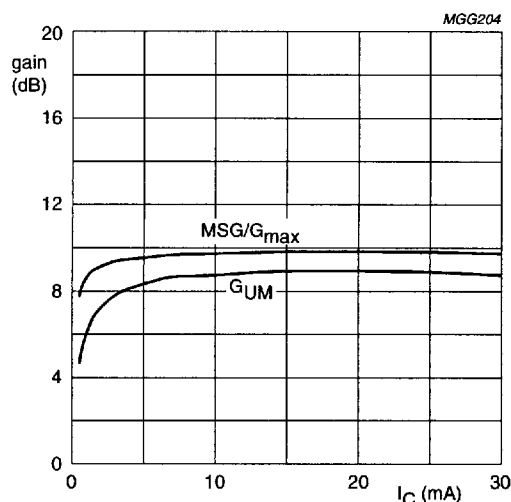
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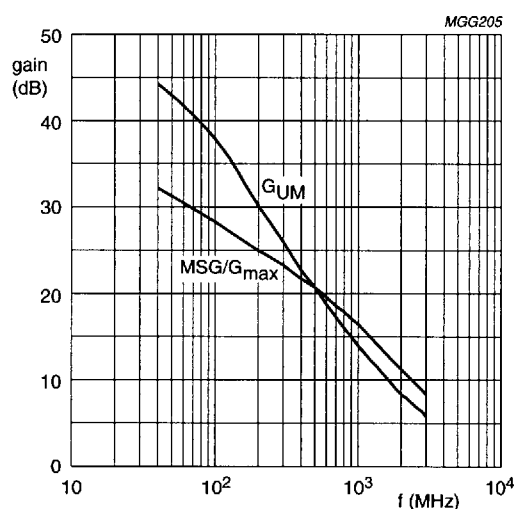
$f = 900 \text{ MHz}$; $V_{CE} = 3 \text{ V}$.

Fig.6 Gain as a function of collector current; typical values.



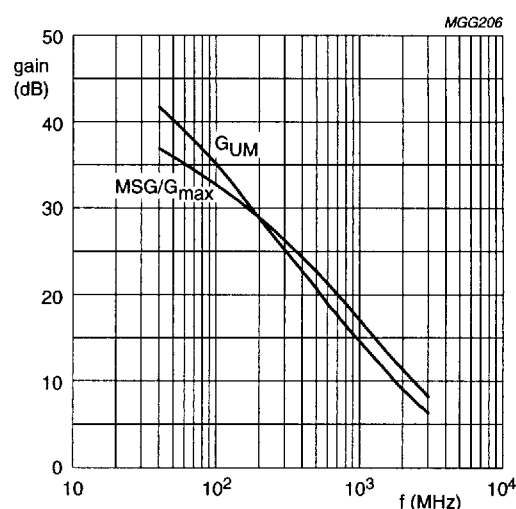
$f = 2 \text{ GHz}$; $V_{CE} = 3 \text{ V}$.

Fig.7 Gain as a function of collector current; typical values.



$I_C = 5 \text{ mA}$; $V_{CE} = 3 \text{ V}$.

Fig.8 Gain as a function of frequency; typical values.



$I_C = 20 \text{ mA}$; $V_{CE} = 3 \text{ V}$.

Fig.9 Gain as a function of frequency; typical values.

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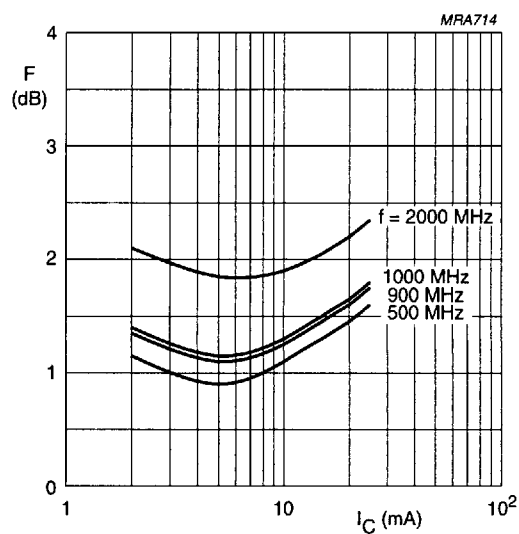
 $V_{CE} = 3$ V.

Fig.10 Minimum noise figure as a function of collector current, typical values.

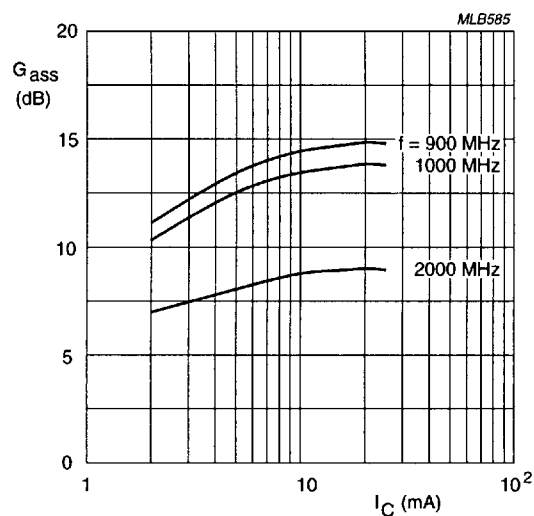
 $V_{CE} = 3$ V.

Fig.11 Associated available gain as a function of collector current, typical values.

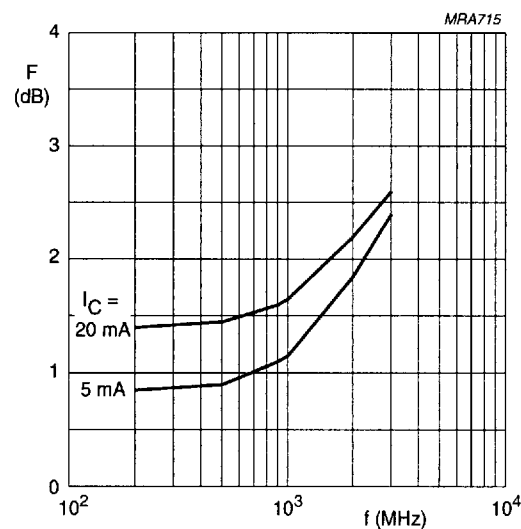
 $V_{CE} = 3$ V.

Fig.12 Minimum noise figure as a function of frequency, typical values.

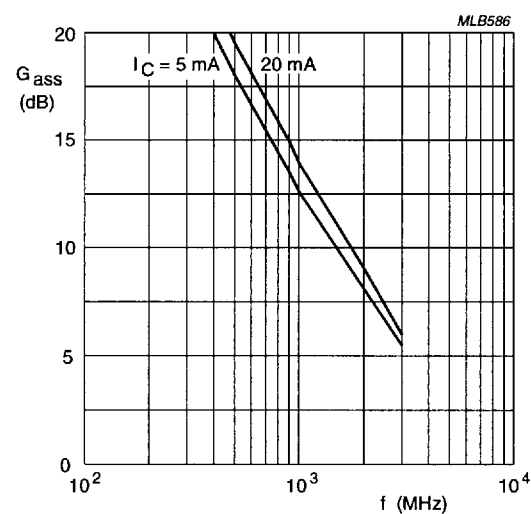
 $V_{CE} = 3$ V.

Fig.13 Associated available gain as a function of frequency, typical values.

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APPLICATION INFORMATION

SPICE parameters for any single BFM520 die

SEQUENCE No.	PARAMETER	VALUE	UNIT
1	IS	1.016	fA
2	BF	220.1	—
3	NF	1.000	—
4	VAF	48.06	V
5	IKF	510.0	mA
6	ISE	283.0	fA
7	NE	2.035	—
8	BR	100.7	—
9	NR	0.988	—
10	VAR	1.692	V
11	IKR	2.352	mA
12	ISC	24.48	aA
13	NC	1.022	—
14	RB	10.00	Ω
15	IRB	1.000	μ A
16	RBM	10.00	Ω
17	RE	0.775	Ω
18	RC	2.210	Ω
19 ⁽¹⁾	XTB	0.000	—
20 ⁽¹⁾	EG	1.110	eV
21 ⁽¹⁾	XTI	3.000	—
22	CJE	1.245	pF
23	VJE	600.0	mV
24	MJE	0.258	—
25	TF	8.616	ps
26	XTF	6.788	—
27	VTF	1.414	V
28	ITF	110.3	mA
29	PTF	45.01	deg
30	CJC	447.6	fF
31	VJC	189.2	mV
32	MJC	0.071	—
33	XCJC	0.130	—
34	TR	543.7	ps
35 ⁽¹⁾	CJS	0.000	F
36 ⁽¹⁾	VJS	750.0	mV
37 ⁽¹⁾	MJS	0.000	—
38	FC	0.780	—

Note

1. These parameters have not been extracted, the default values are shown.

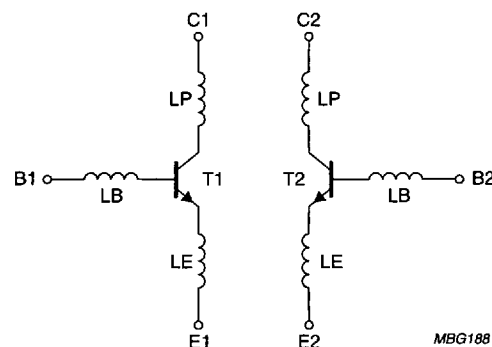


Fig.14 Package equivalent circuit SOT363A (inductance only).

Lead inductances (nH)

LP	0.4
LB	0.6
LE	1.0

E2	3				
E1	27	6			
B2	1	27	3		
C2	3	17	36	48	
C1	48	36	17	3	6
	B1	E2	E1	B2	C2

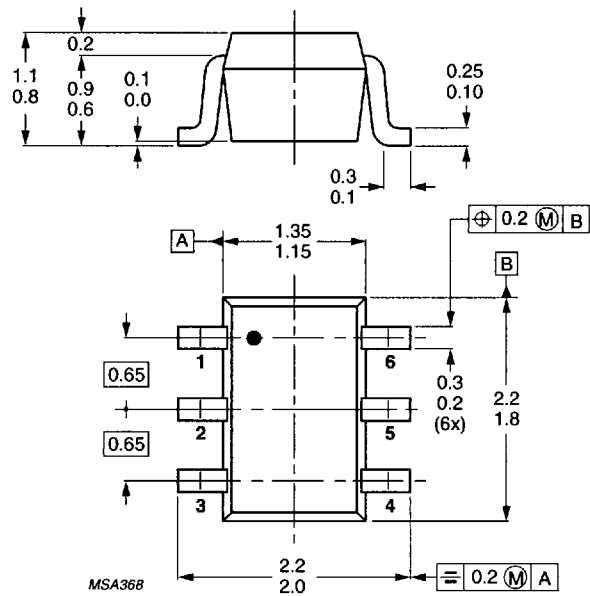
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Fig.15 Package capacitance (fF) between indicated nodes.

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PACKAGE OUTLINE



Dimensions in mm.

Fig.16 SOT363.